



| Report No. | 202109006 |
|-------------|-----------|
| Total pages | 10 |

Test Report

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| Sample: | DCAWI55UP |
|------------|------------------------------------|
| Model: | |
| Test Type: | Commission Test |
| Clientele: | Qingdao Vzense Technology Co., Ltd |

Weifang Semiconductor Lighting Product Testing Center

Weifang Semiconductor Lighting Product Testing Center

Test Report

| Report No.: 202109006 1 / 10 | | | | | | |
|------------------------------|--|-----------------------------|-------------|--|--|--|
| Sample | DCAM550P | Model | / | | | |
| Brand | 1 | 8 | | | | |
| Entrust Unit | Qingdao Vzense Technology Co., Ltd | | | | | |
| Sample Sending Unit | Qingdao Vzense Technology Co., Ltd | | | | | |
| Contact Name | Kim | Telephone | 18562722583 | | | |
| Test Type | Commission Test | Reliability Testing Room | | | | |
| Date of Receival | 2021-09-02 Test Date 2021-09-02-~ 2021-09-10 | | | | | |
| Sample No. | 202109006-001~ 202109006-008 Status of Sample In good condition | | | | | |
| Check Quantity | / Testing Batch No. / | | | | | |
| Standard | Standard See test instructions on page 2 for details | | | | | |
| Test Condition | Damp heat,steady state,Cold,Damp heat,cyclic, Change of temperature,Electrostatic discharge immunity, free fall*,Packing drop (color box, medium box)*, Radiated emission,Shock* | | | | | |
| Test Results | The testing process of the samples is in accordance with the relevant provisions mentioned above. See pages 3 to 9 of this report for testing data. (The Special Stamp for Inspection Report) Date: 201, 11, 2 | | | | | |
| Remark | The test basis and test items marked "*" are not within the scope of CNAS accreditation of our laboratory | | | | | |

Main-Inspector:

Date: yoll, 11. V

Reviewer: Review

Sample description and testing instructions

1, Sample: DCAM550P

2, Model:/

3, Running Conditions: DC12V/POE

4, Testing Instructions:

| | esting matriculars. | | | |
|-----|---|------------------------------|--|---|
| NO. | Standard | Test Condition | Test Conditions | Remark |
| 1 | GB/T2423.3-2016 Environmental testing for electric and electronic products-Part 2:Testing method-Test Cab:Damp heat,steady state | Damp heat,steady state | Startup state, 60°C, 90%RH storage 120h | After the test, stand at room temperature for 2h to fully check the function of the product, and the product is qualified if its appearance structure has no deformation and cracking failure VD55P1CVB8280022P VD55P1CVB8280020P |
| 2 | GB/T2423.1-2008 Environmental testing for electric and electronic products-Part 2: Test methods-Tests A:Cold | Cold | -20°C, stored for 120h | After the test, stand at room temperature for 2h to fully check the function of the product, and the product is qualified if its appearance structure has no deformation and cracking failure VD55P1CVB8280023P VD55P1CVB8280024P |
| 3 | GB/T2423.4-2008 Environmental testing for electric and electronic products-Part 2:Test method- Test Db:Damp heat,cyclic (12h+12h cycle) | Damp heat,cyclic | Boot state, initial humidity 95%, temperature 25°C, 3h to 55°C, humidity 95%, 9h;3h to 25°C, 95% humidity, maintain 9h. This is one loop, of which there are three | After the test, stand at room temperature for 2h to fully check the function of the product, and the product is qualified if its appearance structure has no deformation and cracking failure VD55P1CVB8280022P VD55P1CVB8280020P |
| 4 | GB/T 2423.22-2012 Environmental testing-Part 2:Test methods- Test N:Change of temperature | Change of temperatur e | High Temp:85±3°C; Low Temp:-40±3°C; Each step duration for l h; Transition: < 5 min; Cycel:45 | After the test, stand at room temperature for 2h to fully check the function of the product, and the product is qualified if its appearance structure has no deformation and cracking failure VD55P1CVB8280023P VD55P1CVB8280024P |

| 5 | GB/T 17626.2-2018 Electromagnetic compatibility-Testi ng and measurement techniques-Electros tatic discharge immunity test | Electrostati c discharge immunity | Normal working status/charging status Contact discharge +/-4KV, +/-6KV, air discharge +/-10KV Working status: boot (USB+DC power supply) | 1. Functions after ESD test 2. During the product test process, the working state of the product shall not be changed (but the automatic recovery problem without human intervention is acceptable and meets the NATIONAL standard GRADE B) VD55P1CVB8280021P VD55P1CVB8280026P |
|----|--|---|--|--|
| 6* | Test according to customer requirements, see test conditions | free fall | Floor: slab Height:100cm; Positions:6Surfaces/4C orners Each Surface Drop 2 Times OFF | After each cycle drop test, the appearance structure and basic functions of the product shall be checked. The product structure shall not be cracked that may affect the use of users, and the appearance of slight surface scratches shall be considered as qualified VD55P1CVB8280021P VD55P1CVB8280026P |
| 7* | Test according to customer requirements, see test conditions | Packaging drop | 76cm,One corner, three edges and six sides | The function of the product is OK, allowing the packaging appearance to have wrinkles, the rupture length is less than 1cm |
| 8 | GB/T 9254-2008 Information technology equipment-Radio disturbance characteristics-Lim it and methods of measurement | Radiated emission | Radiated emission : 30MHz-1GHz,A | / |
| 9* | GB/T 2423.5-2019 Environmental testing-Part 2: Test methods-Test Ea and guidance: Shock | Shock | 4axis(±X,±Y)50G 11ms Half sine No Package 40 | Fully check the function of the product, the appearance of the product structure without deformation cracking failure is qualified VD55P1CVB8280022P VD55P1CVB8280020P |

| Test Results | | | | | |
|--------------|--|--|---|---------------------------|---------------|
| NO. | Test Condition | Standard | Test Conditions | Test Results | Determ ine |
| 1 | Damp heat,steady state | GB/T 2423.3-2016 | Startup state, 60°C, 90%RH storage 120h | Meet testing requirements | Р |
| 2 | Cold | GB/T 2423.1-2008 | -20°C, stored for 120h | Meet testing requirements | Р |
| 3 | Damp heat,cyclic | GB/T 2423.4-2008 | Boot state, initial humidity 95%, temperature 25°C, 3h to 55°C, humidity 95%, 9h;3h to 25°C, 95% humidity, maintain 9h.This is one loop, of which there are three | Meet testing requirements | Р |
| 4 | Change of temperature | GB/T 2423.22-2012 | High Temp:85±3°C; Low Temp:-40±3°C; Each step duration for1 h; Transition: < 5 min; Cycel:45 | Meet testing requirements | Р |
| 5 | Electrostatic discharge immunity | GB/T 17626.2-2018 | Normal working status/charging status Contact discharge +/-4KV, +/-6KV, air discharge +/-8KV, +/-10KV Working status: boot (USB+DC power supply) | Meet testing requirements | Р |
| 6* | free fall | Test according to customer requirements, see test conditions | Floor: slab Height:100cm; Positions:6Surfaces/ 4Corners Each Surface Drop 2 Times OFF | Meet testing requirements | Р |
| 7* | Packaging drop | Test according to customer requirements, see test conditions | 76cm,One corner, three edges and six sides | Meet testing requirements | Р |
| 8 | Radiated emission | GB/T 9254-2008 | Radiated emission :30MHz-1GHz,A | Meet testing requirements | P |
| 9* | Shock | GB/T 2423.5-2019 | 4axis(±X,±Y)50G 11ms Half sine No Package 40 | Meet testing requirements | P |

Remark:

- 1, Temp:15°C ~35°C Humidity: 25% ~75%RH
- 2, When uncertainty is required in the test criteria, the uncertainty must be provided.

The uncertainty_/_.

- 3, The test information
 - (1) Damp heat, steady state, Damp heat, cyclic



(2) Cold



(3) Change of temperature



(4) Electrostatic discharge immunity



(5) free fall



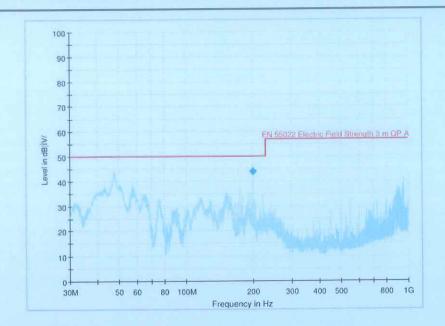
(6) Packaging drop





(7) Radiated emission





| Frequency (MHz) | QuasiPeak (dB¦ i V/m) | MaxPeak (dB¦ Ì V/m | Average (dB¦ Ì V/m | Limit (dB¦ Ì V/m | Margin (dB) | Meas. Time (ms) | Bandwidth (kHz) | Height (cm) | Pol |
|--------------------|--------------------------|-----------------------|-----------------------|---------------------|----------------|-----------------------|--------------------|----------------|-----|
| 200.005556 | 43.79 | | *** | 50.00 | 6.21 | 3000.0 | 120.000 | 192.0 | ٧ |

(8) Shock



4, The testing process

(1) Damp heat, steady state

Before the test, check the appearance of the sample, no obvious damage, put the sample into the high temperature and high humidity test box, high temperature and high humidity test, 60°C, 90%RH storage 120h;After the test, it was recovered for 2 hours at room temperature.

(2) Cold

Before the test, check the appearance of the sample, no obvious damage, put the sample into the low temperature test box, start the sample, conduct the low temperature test, run at -20° C for 120h;After the test, it was recovered for 2 hours at room temperature.

(3) Damp heat, cyclic

Before the test, check the appearance of the sample, no obvious damage, put the sample into the high temperature and high humidity test box, sample boot, high temperature and high

humidity test, initial humidity 95%, temperature 25°C, 3h to 50°C, humidity 95%, maintain 9h;3h to 25°C, 95% humidity, maintain 9h.This is a loop, there are three loops;After the test, it was recovered for 2 hours at room temperature.

(4) Change of temperature

Before the test, the samples were visually inspected and put into the test chamber for cold and hot shock test. The high temperature was set at 85°C and the low temperature was set at -40°C. Each was stored for 30min and 45 cycles were carried out. After the test, it was recovered for 2h at room temperature.

(5) Electrostatic discharge immunity

| Test Site | Test Voltage | Discharge Patterns | Number of Discharge | Criteria | Test Results |
|---------------------------|--------------|-----------------------|---------------------|----------|-----------------|
| Metal case or screw | 4KV | Contact discharge | 10+10 | a | A |
| Metal case or screw | 6KV | Contact discharge | 10+10 | a | A |
| Non-metallic shell or gap | 8KV | Air discharge | 10+10 | a | A |
| Non-metallic shell or gap | 10KV | Air discharge | 10+10 | a | A |

Detection based on

Classification of judgment criteria:

- A) Perform normally within the limits specified by the manufacturer, applicant or user
- B) The function or performance is temporarily reduced or lost, but after the disturbance stops, the test equipment can restore its normal function by itself, requiring operator intervention
- C) Temporary reduction or loss of function or performance, which can only be recovered with operator intervention
- D) Reduced or lost functions that cannot be restored to the normal state by themselves due to hardware or software damage or data loss

Test results:

A: During the test, the sample can work normally without damage, failure or state change; The equipment can work normally after the test

Test specification

Test parts: shell and other personnel operation parts

Test requirements: contact discharge $\pm 4KV$, $\pm 6KV$, air discharge $\pm 8KV$, $\pm 15KV$ interval time $\geq 1s$; Plus and minus 10 each.

(6) free fall

Before the test, check the appearance of the sample, no obvious damage, put the sample into the drop test equipment, set the height of 1m for the test.

(7) Packaging drop

According to the standard, the drop test was carried out on the package of the single product. The drop height was 76cm. After the test, the packaging was visually wrinkled and the rupture length was less than 1cm.

(8) Shock

The sample was fixed on the impact test bench, and the impact test bench was set as half sine wave test, with peak acceleration 50g, pulse width 11ms, $\pm X$, $\pm Y$, and a total of 40 shocks. After the test, the sample can work normally.

Equipment

| NO. | Name | Model | Valid Date of Measurement |
|-----|---|----------------------|------------------------------|
| 1 | High temperature and high humidity test chamber | VC ³ 7150 | 2022.08.31 |
| 2 | Hot and cold shock test chamber (device) | VT3 7012 S2 | 2022.08.31 |
| 3 | Low temperature test chamber | ECT-408-70-CP-SD | 2022.08.30 |
| 4 | Impact test bench | CL-300 | 2022.08.27 |
| 5 | Drop bench | DLJ-200 | 2022.08.27 |
| 6 | EMI test receiver | ESU40 | 2022.08.16 |
| 7 | anechoic chamber | APC15107 | 2025.09.07 |
| 8 | Shielding room | APC15107 | 2025.09.07 |

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